Search Notes

A	1: 4:	: <i>1</i> ^	ontro	
Δnn	IIICAT	INN/L.	ODTEO	ו או
\sim	III			

10/601,940

Applicant(s)/Patent under Reexamination SOSNOWSKI ET AL.

Examiner

Art Unit

Abigail M. Cotton

1617

SEARCHED					
Class	Subclass	Date	Examiner		
514	289,284	6/28/2006	АМС		
514	282,249	6/28/2006	AMC		
514	185	6/28/2006	AMC		
424	195.1	6/28/2006	AMC		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
Inventor Search on Palm	6/28/2006	AMC
EAST (USPAT, USOCR, US-PGPUB, EPO, JPO, DERWENT) - See Serch History Report	6/28/2006	AMC
STN (CAPus, Medline, Embase) - See Search History Report	6/28/2006	AMC